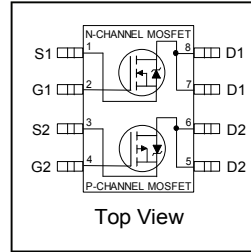


**Features**

- Advanced Planar Technology
- Ultra Low On-Resistance
- Logic Level Gate Drive
- Dual N and P Channel MOSFET
- Surface Mount
- Available in Tape & Reel
- 150°C Operating Temperature
- Lead-Free, RoHS Compliant
- Automotive Qualified \*



|                          | N-CH   | P-CH   |
|--------------------------|--------|--------|
| $V_{DSS}$                | 55V    | -55V   |
| $R_{DS(on)}$ <b>typ.</b> | 0.043Ω | 0.095Ω |
| <b>max.</b>              | 0.050Ω | 0.105Ω |
| $I_D$                    | 4.7A   | -3.4A  |



| G    | D     | S      |
|------|-------|--------|
| Gate | Drain | Source |

**Description**

Specifically designed for Automotive applications, these HEXFET® Power MOSFET's in a Dual SO-8 package utilize the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of these Automotive qualified HEXFET Power MOSFET's are a 150°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These benefits combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.

The efficient SO-8 package provides enhanced thermal characteristics and dual MOSFET die capability making it ideal in a variety of power applications. This dual, surface mount SO-8 can dramatically reduce board space and is also available in Tape & Reel.

| Base part number | Package Type | Standard Pack |          | Orderable Part Number |
|------------------|--------------|---------------|----------|-----------------------|
|                  |              | Form          | Quantity |                       |
| AUIRF7343Q       | SO-8         | Tape and Reel | 4000     | AUIRF7343QTR          |

**Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

| Symbol                   | Parameter   | Max.         |           | Units |
|--------------------------|---|--------------|-----------|-------|
|                          |   | N-Channel    | P-Channel |       |
| $V_{DS}$                 | Drain-Source Voltage                                | 55           | -55       | V     |
| $I_D @ T_A = 25^\circ C$ | Continuous Drain Current, $V_{GS} @ 10V$            | 4.7          | -3.4      | A     |
| $I_D @ T_A = 70^\circ C$ | Continuous Drain Current, $V_{GS} @ 10V$            | 3.8          | -2.7      |       |
| $I_{DM}$                 | Pulsed Drain Current ①                              | 38           | -27       |       |
| $P_D @ T_A = 25^\circ C$ | Maximum Power Dissipation ⑤                         | 2.0          |           | W     |
| $P_D @ T_A = 70^\circ C$ | Maximum Power Dissipation ⑤                         | 1.3          |           |       |
| $E_{AS}$                 | Single Pulse Avalanche Energy (Thermally Limited) ③ | 72           | 114       | mJ    |
| $I_{AR}$                 | Avalanche Current                                   | 4.7          | -3.4      | A     |
| $E_{AR}$                 | Repetitive Avalanche Energy                         | 0.20         |           | mJ    |
| $V_{GS}$                 | Gate-to-Source Voltage                              | $\pm 20$     |           | V     |
| dv/dt                    | Peak Diode Recovery dv/dt ②                         | 5.0          | -5.0      | V/ns  |
| $T_J$<br>$T_{STG}$       | Operating Junction and<br>Storage Temperature Range | -55 to + 150 |           | °C    |

**Thermal Resistance**

| Symbol          | Parameter  | Typ. | Max. | Units |
|-----------------|--|------|------|-------|
| $R_{\theta JA}$ | Junction-to-Ambient ( PCB Mount, steady state) ⑤ | —    | 62.5 | °C/W  |

HEXFET® is a registered trademark of Infineon.

\*Qualification standards can be found at [www.infineon.com](http://www.infineon.com)

**Static @ T<sub>J</sub> = 25°C (unless otherwise specified)**

|  | Parameter                            |      | Min. | Typ.  | Max.  | Units | Conditions  |
|--|--------------------------------------|------|------|-------|-------|-------|---|
| V <sub>(BR)DSS</sub>                   | Drain-to-Source Breakdown Voltage    | N-Ch | 55   | —     | —     | V     | V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA                        |
|  |                                      | P-Ch | -55  | —     | —     |       | V <sub>GS</sub> = 0V, I <sub>D</sub> = -250μA                       |
| ΔV <sub>(BR)DSS</sub> /ΔT <sub>J</sub> | Breakdown Voltage Temp. Coefficient  | N-Ch | —    | 0.059 | —     | V/°C  | Reference to 25°C, I <sub>D</sub> = 1mA                             |
|  |                                      | P-Ch | —    | 0.054 | —     |       | Reference to 25°C, I <sub>D</sub> = -1mA                            |
| R <sub>DS(on)</sub>                    | Static Drain-to-Source On-Resistance | N-Ch | —    | 0.043 | 0.050 | Ω     | V <sub>GS</sub> = 10V, I <sub>D</sub> = 4.7A ④                      |
|  |                                      |      | —    | 0.056 | 0.065 |       | V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 3.8A ④                     |
|  |                                      | P-Ch | —    | 0.095 | 0.105 |       | V <sub>GS</sub> = -10V, I <sub>D</sub> = -3.4A ⑤                    |
|  |                                      |      | —    | 0.150 | 0.170 |       | V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -2.7A ④                   |
| V <sub>GS(th)</sub>                    | Gate Threshold Voltage               | N-Ch | 1.0  | —     | —     | V     | V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250μA          |
|  |                                      | P-Ch | -1.0 | —     | —     |       | V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = -250μA         |
| g <sub>fs</sub>                        | Forward Trans conductance            | N-Ch | 7.9  | —     | —     | S     | V <sub>DS</sub> = 10V, I <sub>D</sub> = 4.5A④                       |
|  |                                      | P-Ch | 3.3  | —     | —     |       | V <sub>DS</sub> = -10V, I <sub>D</sub> = -3.1A④                     |
| I <sub>DSS</sub>                       | Drain-to-Source Leakage Current      | N-Ch | —    | —     | 2.0   | μA    | V <sub>DS</sub> = 55V, V <sub>GS</sub> = 0V                         |
|  |                                      | P-Ch | —    | —     | -2.0  |       | V <sub>DS</sub> = -55V, V <sub>GS</sub> = 0V                        |
|  |                                      | N-Ch | —    | —     | 25    |       | V <sub>DS</sub> = 55V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 55°C  |
|  |                                      | P-Ch | —    | —     | -25   |       | V <sub>DS</sub> = -55V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 55°C |
| I <sub>GSS</sub>                       | Gate-to-Source Forward Leakage       | N-P  | —    | —     | ± 100 | nA    | V <sub>GS</sub> = ± 20V   |
|  | Gate-to-Source Reverse Leakage       | N-P  | —    | —     | ± 100 |       | V <sub>GS</sub> = ± 20V   |

**Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)**

|                     |                              |      |   |     |     |    |   |
|---------------------|------------------------------|------|---|-----|-----|----|---|
| Q <sub>g</sub>      | Total Gate Charge            | N-Ch | — | 24  | 36  | nC | N-Channel<br>I <sub>D</sub> = 4.5A, V <sub>DS</sub> = 44V, V <sub>GS</sub> = 10V ④                            |
|                     |                              | P-Ch | — | 26  | 38  |    |   |
| Q <sub>gs</sub>     | Gate-to-Source Charge        | N-Ch | — | 2.3 | 3.4 | nC | P-Channel<br>I <sub>D</sub> = -3.1A, V <sub>DS</sub> = -44V, V <sub>GS</sub> = -10V                           |
|                     |                              | P-Ch | — | 3.0 | 4.5 |    |   |
| Q <sub>gd</sub>     | Gate-to-Drain Charge         | N-Ch | — | 7.0 | 10  | nC | P-Channel<br>I <sub>D</sub> = -3.1A, V <sub>DS</sub> = -44V, V <sub>GS</sub> = -10V                           |
|                     |                              | P-Ch | — | 8.4 | 13  |    |   |
| t <sub>d(on)</sub>  | Turn-On Delay Time           | N-Ch | — | 8.3 | 12  | ns | N-Channel<br>V <sub>DD</sub> = 28V, I <sub>D</sub> = 1.0A, R <sub>G</sub> = 6.0Ω,<br>R <sub>D</sub> = 28Ω ④   |
|                     |                              | P-Ch | — | 14  | 22  |    |   |
| t <sub>r</sub>      | Rise Time                    | N-Ch | — | 3.2 | 4.8 | ns | P-Channel<br>V <sub>DD</sub> = -28V, I <sub>D</sub> = -1.0A, R <sub>G</sub> = 6.0Ω,<br>R <sub>D</sub> = 28Ω ④ |
|                     |                              | P-Ch | — | 10  | 15  |    |   |
| t <sub>d(off)</sub> | Turn-Off Delay Time          | N-Ch | — | 32  | 48  | ns | P-Channel<br>V <sub>DD</sub> = -28V, I <sub>D</sub> = -1.0A, R <sub>G</sub> = 6.0Ω,<br>R <sub>D</sub> = 28Ω ④ |
|                     |                              | P-Ch | — | 43  | 64  |    |   |
| t <sub>f</sub>      | Fall Time                    | N-Ch | — | 13  | 20  | ns | P-Channel<br>V <sub>DD</sub> = -28V, I <sub>D</sub> = -1.0A, R <sub>G</sub> = 6.0Ω,<br>R <sub>D</sub> = 28Ω ④ |
|                     |                              | P-Ch | — | 22  | 32  |    |   |
| C <sub>iss</sub>    | Input Capacitance            | N-Ch | — | 740 | —   | pF | N-Channel<br>V <sub>GS</sub> = 0V, V <sub>DS</sub> = 25V, f = 1.0MHz  |
|                     |                              | P-Ch | — | 690 | —   |    |   |
| C <sub>oss</sub>    | Output Capacitance           | N-Ch | — | 190 | —   | pF | P-Channel<br>V <sub>GS</sub> = 0V, V <sub>DS</sub> = -25V, f = 1.0MHz   |
|                     |                              | P-Ch | — | 210 | —   |    |   |
| C <sub>rss</sub>    | Reverse Transfer Capacitance | N-Ch | — | 71  | —   | pF | P-Channel<br>V <sub>GS</sub> = 0V, V <sub>DS</sub> = -25V, f = 1.0MHz   |
|                     |                              | P-Ch | — | 86  | —   |    |   |

**Diode Characteristics**

|                 | Parameter                              |      | Min. | Typ.  | Max. | Units | Conditions  |
|-----------------|--|------|------|-------|------|-------|---|
| I <sub>S</sub>  | Continuous Source Current (Body Diode) | N-Ch | —    | —     | 2.0  | A     |   |
|                 |  | P-Ch | —    | —     | -2.0 |       |   |
| I <sub>SM</sub> | Pulsed Source Current (Body Diode) ①   | N-Ch | —    | —     | 38   | A     |   |
|                 |  | P-Ch | —    | —     | -27  |       |   |
| V <sub>SD</sub> | Diode Forward Voltage                  | N-Ch | —    | 0.70  | 1.2  | V     | T <sub>J</sub> = 25°C, I <sub>S</sub> = 2.0A, V <sub>GS</sub> = 0V ④          |
|                 |  | P-Ch | —    | -0.80 | -1.2 |       | T <sub>J</sub> = 25°C, I <sub>S</sub> = -2.0A, V <sub>GS</sub> = 0V ④         |
| t <sub>rr</sub> | Reverse Recovery Time                  | N-Ch | —    | 60    | 90   | ns    | N-Channel<br>T <sub>J</sub> = 25°C, I <sub>F</sub> = 2.0A, di/dt = 100A/μs    |
|                 |  | P-Ch | —    | 54    | 80   |       |   |
| Q <sub>rr</sub> | Reverse Recovery Charge                | N-Ch | —    | 120   | 170  | nC    | P-Channel<br>T <sub>J</sub> = 25°C, I <sub>F</sub> = -2.0A, di/dt = 100A/μs ④ |
|                 |  | P-Ch | —    | 85    | 130  |       |   |

**Notes:**

- ① Repetitive rating; pulse width limited by max. junction temperature. (See Fig. 22)
- ② N-Channel I<sub>SD</sub> ≤ 4.7A, di/dt ≤ 220A/μs, V<sub>DD</sub> ≤ V<sub>(BR)DSS</sub>, T<sub>J</sub> ≤ 150°C.  
P-Channel I<sub>SD</sub> ≤ -3.4A, di/dt ≤ -150A/μs, V<sub>DD</sub> ≤ V<sub>(BR)DSS</sub>, T<sub>J</sub> ≤ 150°C
- ③ N-Channel Starting T<sub>J</sub> = 25°C, L = 6.5mH, R<sub>G</sub> = 25Ω, I<sub>AS</sub> = 4.7A.  
P-Channel Starting T<sub>J</sub> = 25°C, L = 20mH, R<sub>G</sub> = 25Ω, I<sub>AS</sub> = -3.4A.
- ④ Pulse width ≤ 300μs; duty cycle ≤ 2%.
- ⑤ Surface mounted on FR-4 board, t ≤ 10sec.

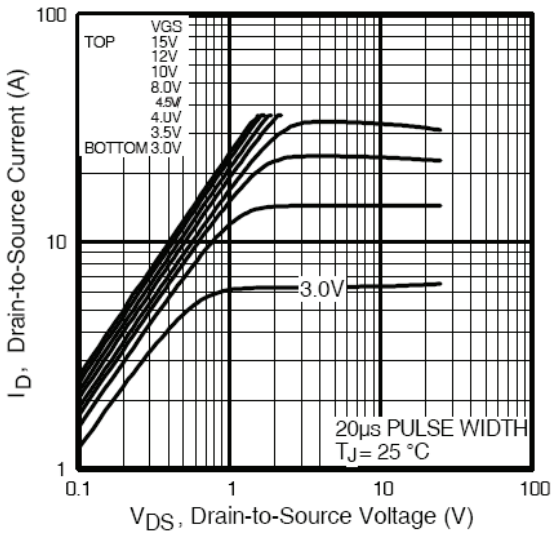


Fig. 1 Typical Output Characteristics

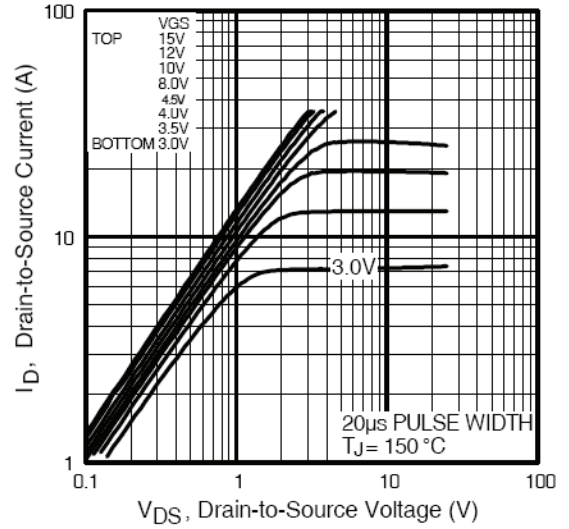


Fig. 2 Typical Output Characteristics

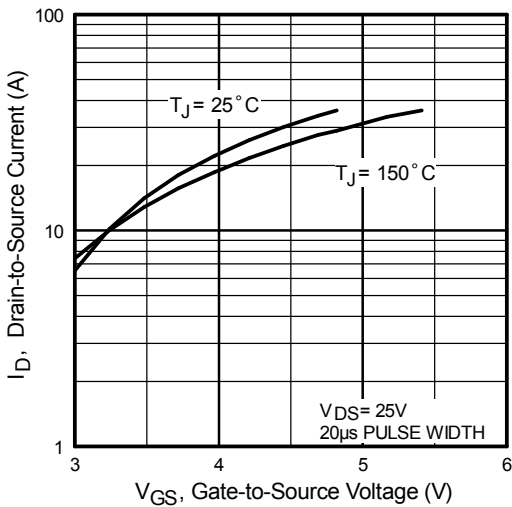


Fig. 3 Typical Transfer Characteristics

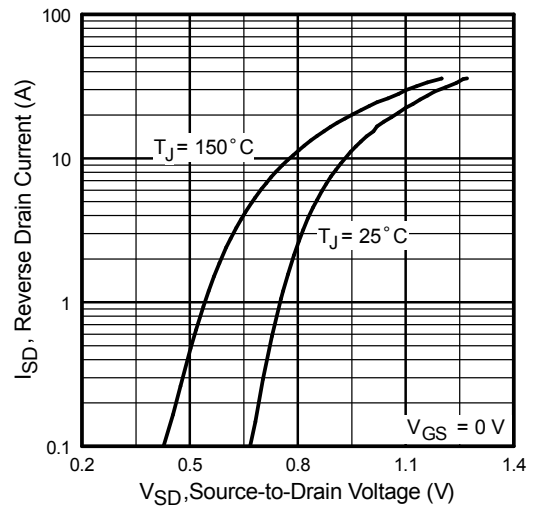
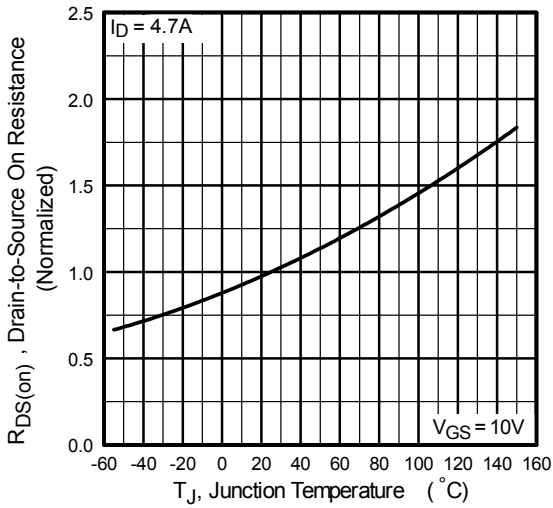
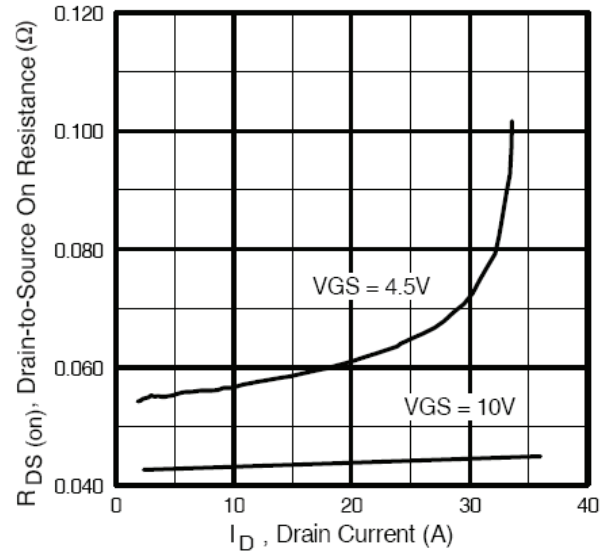


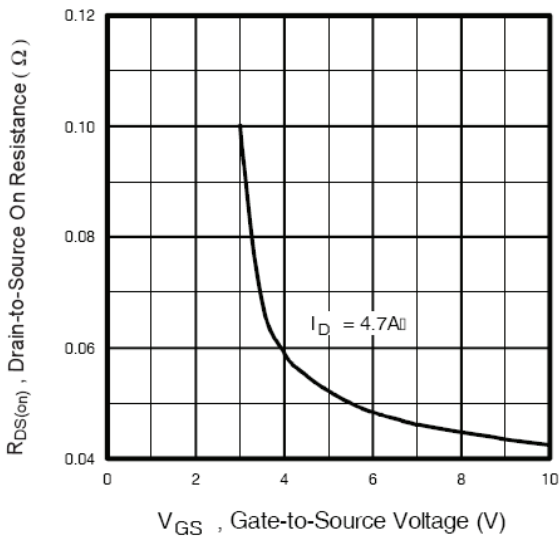
Fig. 4 Typical Source-Drain Diode Forward Voltage



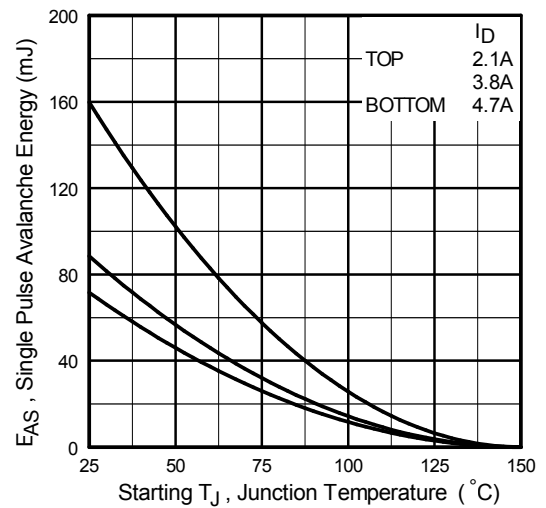
**Fig 5.** Normalized On-Resistance Vs. Temperature



**Fig 6.** Typical On-Resistance Vs. Drain Current



**Fig 7** Typical On-Resistance Vs. Gate Voltage



**Fig 8.** Maximum Avalanche Energy Vs. Drain Current

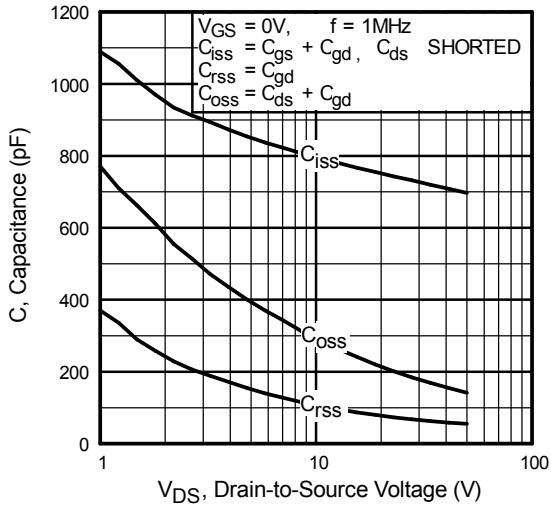


Fig 9. Typical Capacitance Vs. Drain-to-Source Voltage

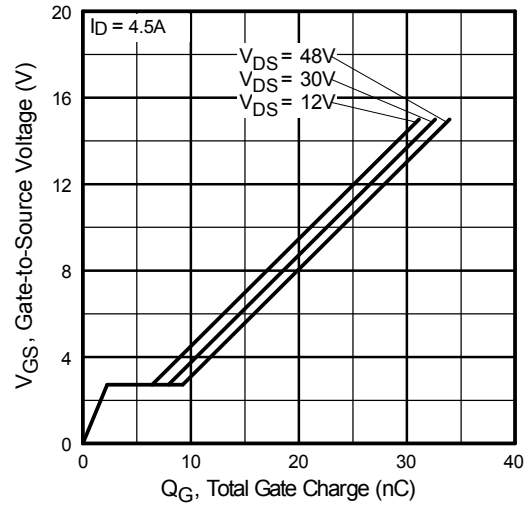


Fig 10. Typical Gate Charge Vs. Gate-to-Source Voltage

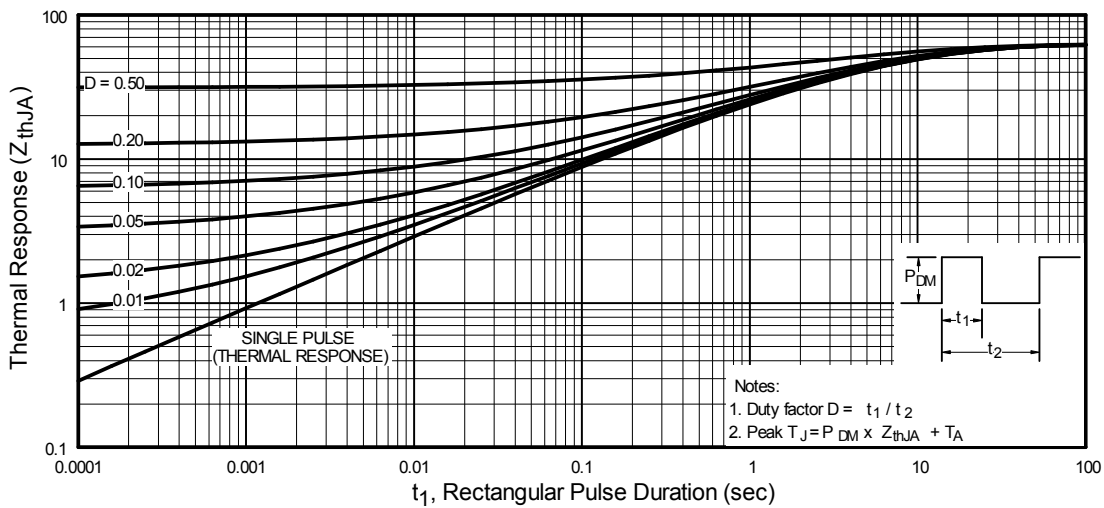


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

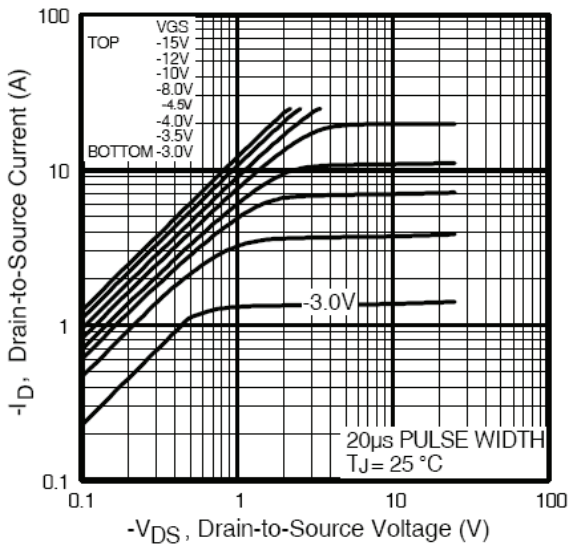


Fig. 12 Typical Output Characteristics

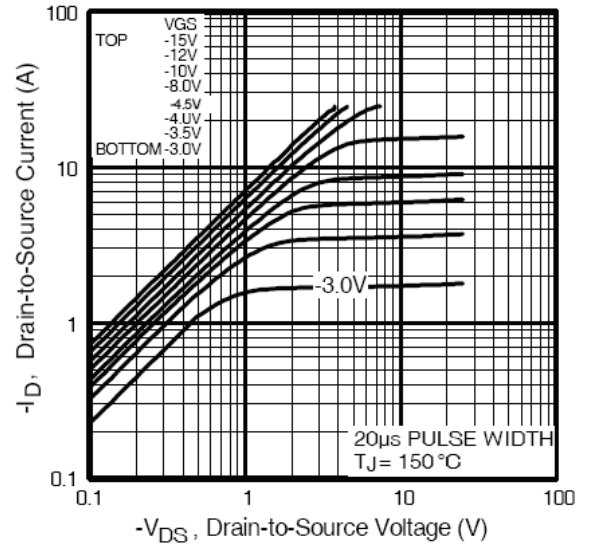


Fig. 13 Typical Output Characteristics

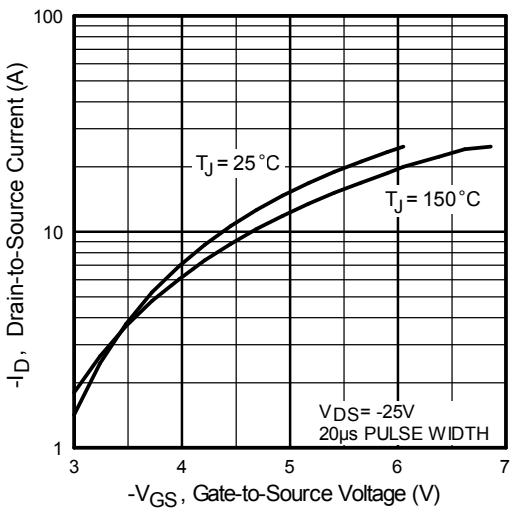


Fig. 14 Typical Transfer Characteristics

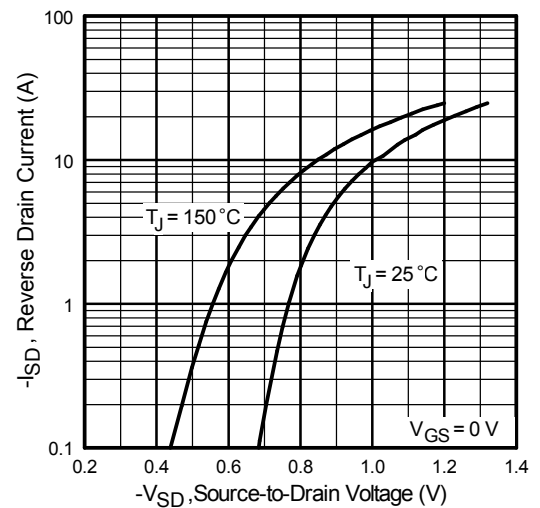
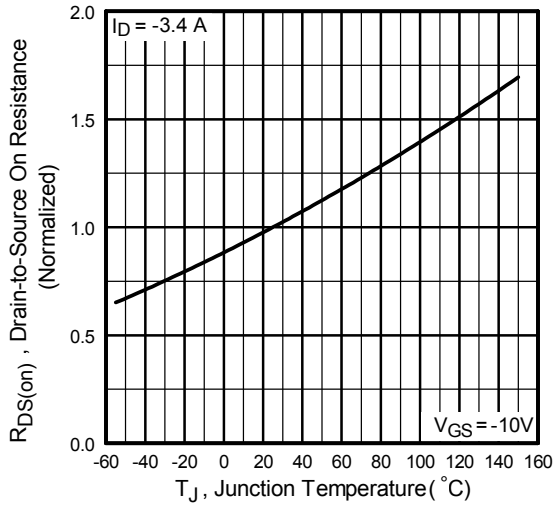
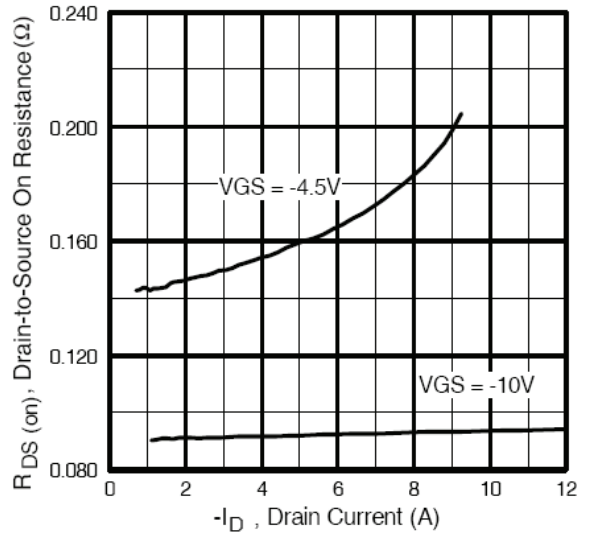


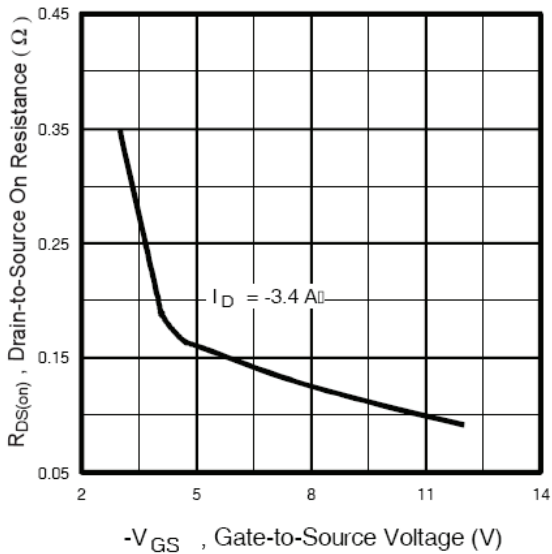
Fig. 15 Typical Source-Drain Diode Forward Voltage



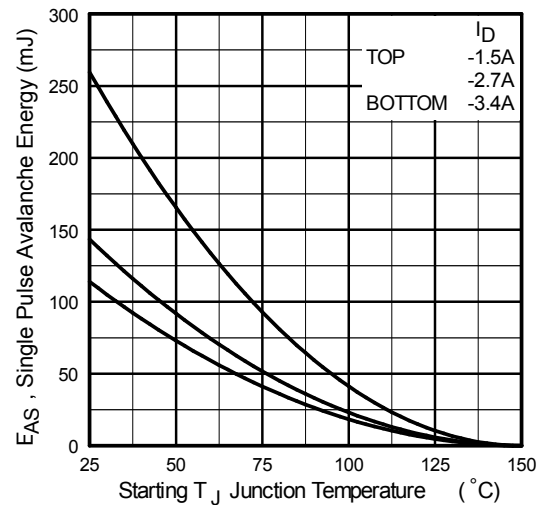
**Fig 16.** Normalized On-Resistance Vs. Temperature



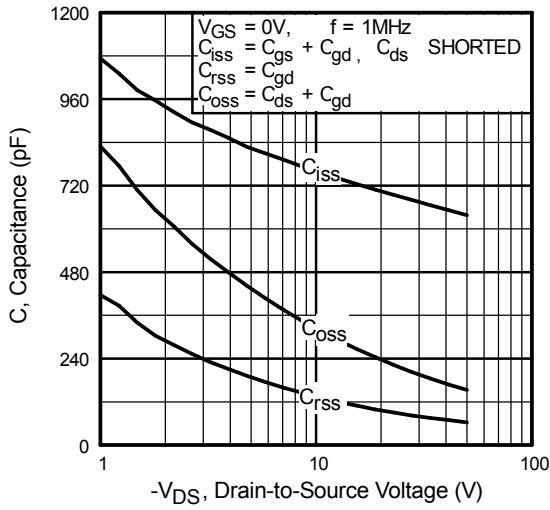
**Fig 17.** Typical On-Resistance Vs. Drain Current



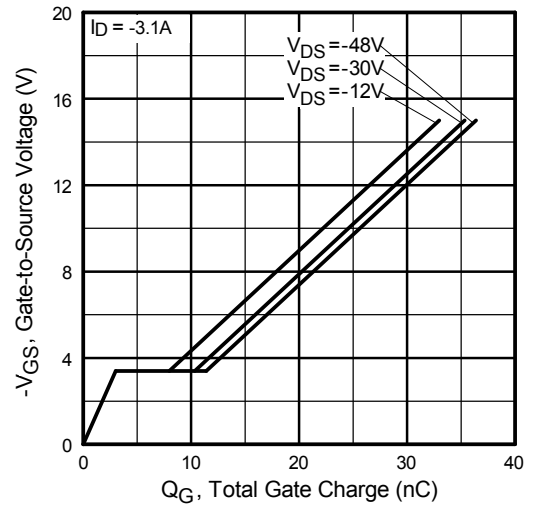
**Fig 18** Typical On-Resistance Vs. Gate Voltage



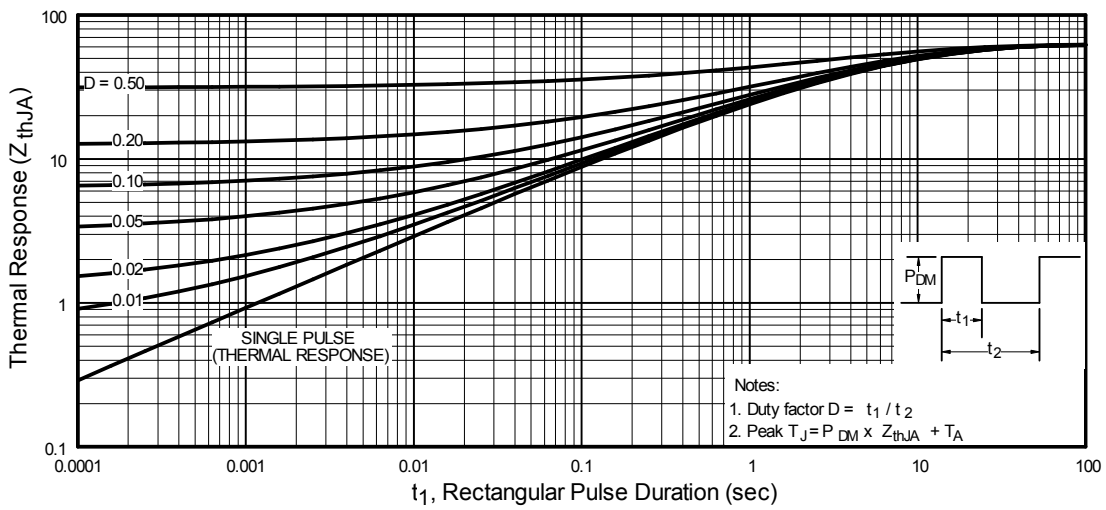
**Fig 19.** Maximum Avalanche Energy Vs. Drain Current



**Fig 20.** Typical Capacitance Vs. Drain-to-Source Voltage



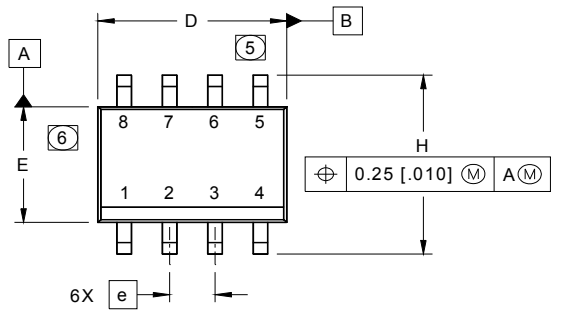
**Fig 21.** Typical Gate Charge Vs. Gate-to-Source Voltage



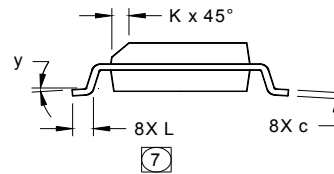
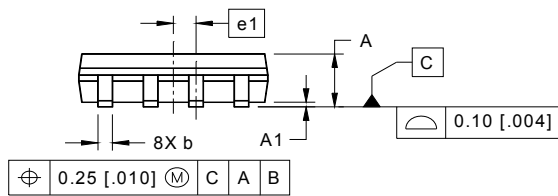
**Fig 22.** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient



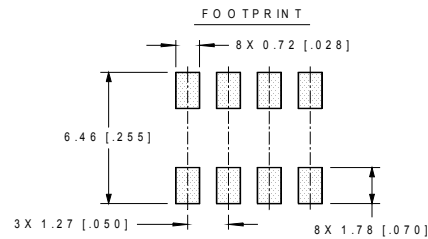
## SO-8 Package Outline (Dimensions are shown in millimeters (inches))



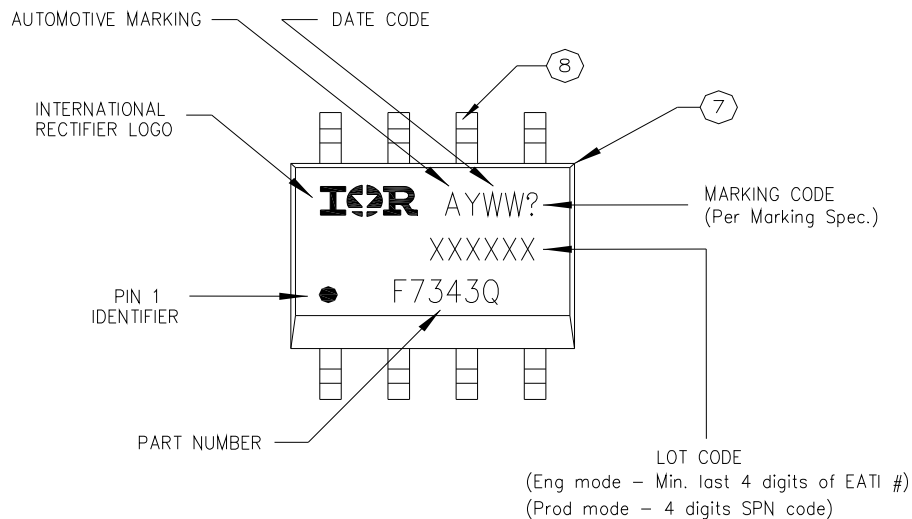
| DIM | INCHES     |       | MILLIMETERS |      |
|-----|------------|-------|-------------|------|
|     | MIN        | MAX   | MIN         | MAX  |
| A   | .0532      | .0688 | 1.35        | 1.75 |
| A1  | .0040      | .0098 | 0.10        | 0.25 |
| b   | .013       | .020  | 0.33        | 0.51 |
| c   | .0075      | .0098 | 0.19        | 0.25 |
| D   | .189       | .1968 | 4.80        | 5.00 |
| E   | .1497      | .1574 | 3.80        | 4.00 |
| e   | .050 BASIC |       | 1.27 BASIC  |      |
| e 1 | .025 BASIC |       | 0.635 BASIC |      |
| H   | .2284      | .2440 | 5.80        | 6.20 |
| K   | .0099      | .0196 | 0.25        | 0.50 |
| L   | .016       | .050  | 0.40        | 1.27 |
| y   | 0°         | 8°    | 0°          | 8°   |

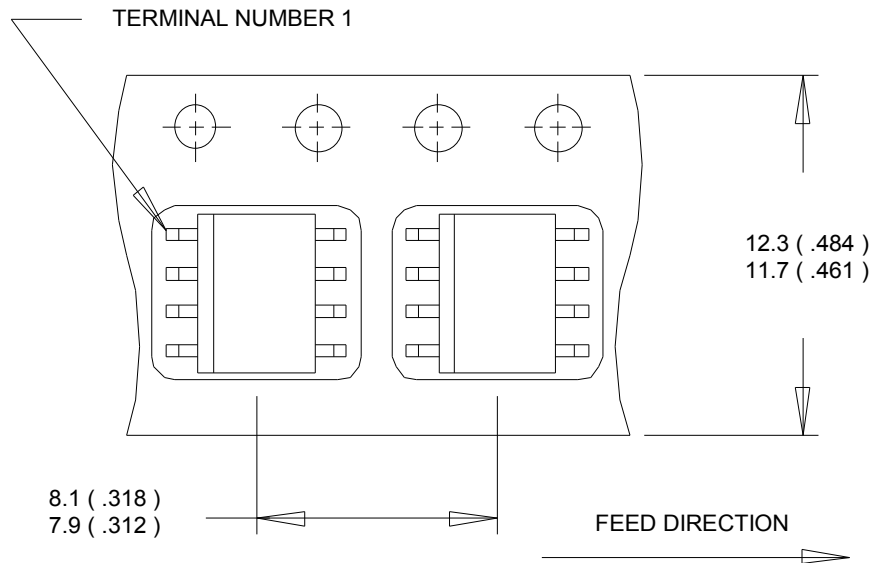


- NOTES:
1. DIMENSIONING & TOLERANCING PER ASME Y14.5M -1994.
  2. CONTROLLING DIMENSION: MILLIMETER
  3. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
  4. OUTLINE CONFORMS TO JEDEC OUTLINE MS-012AA.
  5. DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.15 [0.006].
  6. DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.25 [0.010].
  7. DIMENSION IS THE LENGTH OF LEAD FOR SOLDERING TO A SUBSTRATE.



## SO-8 Part Marking Information



**SO-8 Tape and Reel** (Dimensions are shown in millimeters (inches))

**NOTES:**

1. CONTROLLING DIMENSION : MILLIMETER.
2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).
3. OUTLINE CONFORMS TO EIA-481 & EIA-541.


**NOTES :**

1. CONTROLLING DIMENSION : MILLIMETER.
2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

**Qualification Information**

|                                   |                      |   |      |
|-----------------------------------|----------------------|---|------|
| <b>Qualification Level</b>        |                      | Automotive<br>(per AEC-Q101)  |      |
|                                   |                      | Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level. |      |
| <b>Moisture Sensitivity Level</b> |                      | SO-8  | MSL1 |
| <b>ESD</b>                        | Machine Model        | Class M2 (+/- 200V) <sup>†</sup><br>AEC-Q101-002  |      |
|                                   | Human Body Model     | Class H1A (+/- 500V) <sup>†</sup><br>AEC-Q101-001   |      |
|                                   | Charged Device Model | Class C5 (+/- 1125V) <sup>†</sup><br>AEC-Q101-005   |      |
| <b>RoHS Compliant</b>             |                      | Yes   |      |

† Highest passing voltage.

**Revision History**

| Date      | Comments   |
|-----------|--|
| 3/10/2014 | <ul style="list-style-type: none"> <li>Added "Logic Level Gate Drive" bullet in the features section on page 1</li> <li>Updated data sheet with new IR corporate template</li> </ul> |
| 9/30/2015 | <ul style="list-style-type: none"> <li>Updated datasheet with corporate template</li> <li>Corrected ordering table on page 1.</li> </ul>   |

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